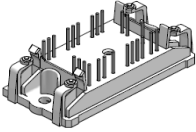
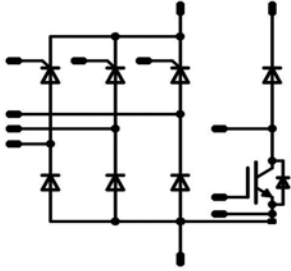


flowCON 0	1200V / 50A
<div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Features</p> <ul style="list-style-type: none"> Input rectifier Optionally with brake chopper Vincotech clip-in housing </div> <div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Target Applications</p> <ul style="list-style-type: none"> Motor drives UPS </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Types</p> <ul style="list-style-type: none"> V23990-P649-G10-PM with brake chopper V23990-P649-H10-PM without brake chopper </div>	<div style="border: 1px solid black; padding: 5px; margin-bottom: 10px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">flow0 housing</p>  </div> <div style="border: 1px solid black; padding: 5px;"> <p style="text-align: center; background-color: #000080; color: white; margin: 0;">Schematic</p>  </div>

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Input Rectifier Diode				
Repetitive peak reverse voltage	V_{RRM}		1600	V
Forward current per diode	I_{FAV}	DC current $T_j=T_{jmax}$ $T_h=80^\circ\text{C}$	50	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ half sine wave $T_j=45^\circ\text{C}$	600	A
I^2t -value	I^2t		1800	A^2s
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^\circ\text{C}$	60	W
Maximum junction temperature	T_{jmax}		150	$^\circ\text{C}$
Input Rectifier Thyristor				
Repetitive peak reverse voltage	V_{RRM}	$T_j=25^\circ\text{C}$	1600	V
Forward average current	I_{FAV}	DC current $T_j=T_{jmax}$ $T_h=80^\circ\text{C}$	34	A
Surge forward current	I_{FSM}	$t_p=10\text{ms}$ half sine wave $T_j=130^\circ\text{C}$	340	A
I^2t -value	I^2t		575	A^2s
Power dissipation per Thyristor	P_{tot}	$T_j=T_{jmax}$ $T_h=80^\circ\text{C}$	43	W
Maximum junction temperature	T_{jmax}		130	$^\circ\text{C}$

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Transistor BRC Not included in V23990-P649-H10-PM model				
Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j = T_{jmax}$ $T_h = 80^\circ C$	25	A
Repetitive peak collector current	I_{cpuls}	t_p limited by T_{jmax} $T_h = 80^\circ C$	75	A
Power dissipation per IGBT	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$	57	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings*	t_{SC}	$T_j \leq 150^\circ C$	10	μs
	V_{CC}	$V_{GE} = 15V$	1200	V
Maximum junction temperature	T_{jmax}		150	$^\circ C$
* It is recommended to not exceed 1000 short circuit situations in the lifetime of the module and to allow at least 1s between short circuits				
BRC inverse diode Not included in V23990-P649-H10-PM model				
Peak Repetitive Reverse Voltage	V_{RRM}	$T_j = 25^\circ C$	1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ C$	6	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	6	A
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$	18	W
Maximum junction temperature	T_{jmax}		150	$^\circ C$
Diode BRC Not included in V23990-P649-H10-PM model				
Peak Repetitive Reverse Voltage	V_{RRM}	$T_j = 25^\circ C$	1200	V
DC forward current	I_F	$T_j = T_{jmax}$ $T_h = 80^\circ C$	15	A
Repetitive peak forward current	I_{FRM}	t_p limited by T_{jmax}	30	A
Power dissipation per Diode	P_{tot}	$T_j = T_{jmax}$ $T_h = 80^\circ C$	33	W
Maximum junction temperature	T_{jmax}		150	$^\circ C$
Thermal properties				
Storage temperature	T_{stg}		-40...+125	$^\circ C$
Operation temperature	T_{op}		-40...+110	$^\circ C$

Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Insulation properties				
Insulation voltage	V_{is}	$t=1\text{min}$	4000	Vdc
Creepage distance			min 12.7	mm
Clearance			min 12.7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}(V)$ or $V_{GS}(V)$	$V_r(V)$ or $V_{CE}(V)$ or $V_{DS}(V)$	$I_c(A)$ or $I_f(A)$ or $I_p(A)$	$T(^{\circ}C)$	Min	Typ	Max		
Input Rectifier Bridge										
Forward voltage	V_F			50	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	1	1,14 1,09	1,5		V
Threshold voltage (for power loss calc. only)	V_{Io}				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		0,90 0,77			V
Slope resistance (for power loss calc. only)	r_t				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		5 7			m Ω
Reverse leakage current	I_r			1500	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			0,02 3		mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 0.61W/mK$						1,17		K/W
Thermal resistance chip to case per chip	R_{thJC}							n.A.		K/W
Input Rectifier Thyristor										
Forward voltage	V_F			50	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	1	1,37 1,45	1,85		V
Threshold voltage (for power loss calc. only)	V_{Io}				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		0,91 0,83			V
Slope resistance (for power loss calc. only)	r_t				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		9 12			m Ω
Reverse current	I_r			1500	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			0,2		mA
Gate controlled delay time	t_{GD}	$I_g=1A$ $di/dt=1A/s$		1072	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		1			μs
Gate controlled rise time	t_{GR}	$I_g=1A$ $di/dt=1A/s$		1072	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		2			μs
Critical rate of rise of off-state voltage	$(dv/dt)_{cr}$				$T_j=25^{\circ}C$ $T_j=130^{\circ}C$			1000		V/ μs
Critical rate of rise of on-state current	$(di/dt)_{cr}$				$T_j=25^{\circ}C$ $T_j=130^{\circ}C$			50		A/ μs
Circuit-commutated turn-off time	t_q				$T_j=25^{\circ}C$ $T_j=130^{\circ}C$			150		μs
Holding current	I_H				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$				165	mA
Latching current	I_L				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$				330	mA
Gate trigger voltage	V_{GT}				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$				1,98	V
Gate trigger current	I_{GT}				$T_j=25^{\circ}C$ $T_j=125^{\circ}C$				100	mA
Gate non-trigger voltage	V_{GD}				$T_j=25^{\circ}C$ $T_j=130^{\circ}C$	0,25				V
Gate non-trigger current	I_{GD}				$T_j=25^{\circ}C$ $T_j=115^{\circ}C$	6				mA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 0.61W/mK$						1,28		K/W
Thermal resistance chip to case per chip	R_{thJC}							n.A.		K/W

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}(V)$ or $V_{ES}(V)$	$V_r(V)$ or $V_{CE}(V)$ or $V_{DS}(V)$	$I_c(A)$ or $I_f(A)$ or $I_b(A)$	$T(^{\circ}C)$	Min	Typ	Max		
Transistor BRC										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,001	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	5	5,8	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		25	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	1,3	1,63 1,84	2,2	V
Collector-emitter cut-off	I_{CES}		0	1200		$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			0,25	mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			650	nA
Integrated Gate resistor	R_{gint}							8		Ω
Turn-on delay time	$t_{d(on)}$	$R_{gon}=32\Omega$ $R_{goff}=16\Omega$	15	600	25	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		53		ns
Rise time	t_r					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		21		ns
Turn-off delay time	$t_{d(off)}$					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		617		ns
Fall time	t_f					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		183		ns
Turn-on energy loss per pulse	E_{on}					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		1,97		mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		2,85		mWs
Input capacitance	C_{ras}							1,808		nF
Output capacitance	C_{oss}	$f=1MHz$	0	25		$T_j=25^{\circ}C$		0,095		nF
Reverse transfer capacitance	C_{rfs}							0,082		nF
Gate charge	Q_{Gate}		15	960	25	$T_j=25^{\circ}C$		155		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda=0.61W/mK$						1,24		K/W
Thermal resistance chip to case per chip	R_{thJC}								n.A.	

Characteristic Values

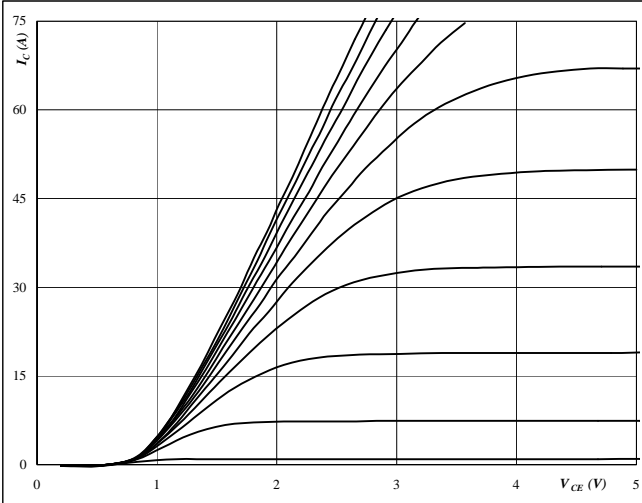
Parameter	Symbol	Conditions					Value			Unit
		$V_{GE}(V)$ or $V_{GS}(V)$	$V_r(V)$ or $V_{CE}(V)$ or $V_{DS}(V)$	$I_c(A)$ or $I_r(A)$ or $I_p(A)$	$T(^{\circ}C)$	Min	Typ	Max		
BRC inverse diode										
Diode forward voltage	V_F				3	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	1	1,65 1,58	2,3	V
Reverse leakage current	I_r			1200		$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			250	μA
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 0,61W/mK$						3,8		K/W
Thermal resistance chip to case per chip	R_{thJC}							n.A.		K/W
Diode BRC										
Diode forward voltage	V_F				25	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$	1	1,75 1,69	2,4	V
Reverse leakage current	I_r			1200		$T_j=25^{\circ}C$ $T_j=125^{\circ}C$			250	μA
Peak reverse recovery current	I_{RRM}	$R_{goff}=32\Omega$ $R_{goff}=16\Omega$	15	600	25	$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		44,2		A
Reverse recovery time	t_{rr}					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		196		ns
Reverse recovered charge	Q_{rr}					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		3,44		μC
Peak rate of fall of reverse recovery current	$di(rec)max/dt$					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		2371		A/ μs
Reverse recovery energy	E_{rec}					$T_j=25^{\circ}C$ $T_j=125^{\circ}C$		1,34		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu m$ $\lambda = 0,61W/mK$						2,11		K/W
Thermal resistance chip to case per chip	R_{thJC}							n.A.		K/W

Brake

Figure 1 Brake IGBT

Typical output characteristics

$I_C = f(V_{CE})$



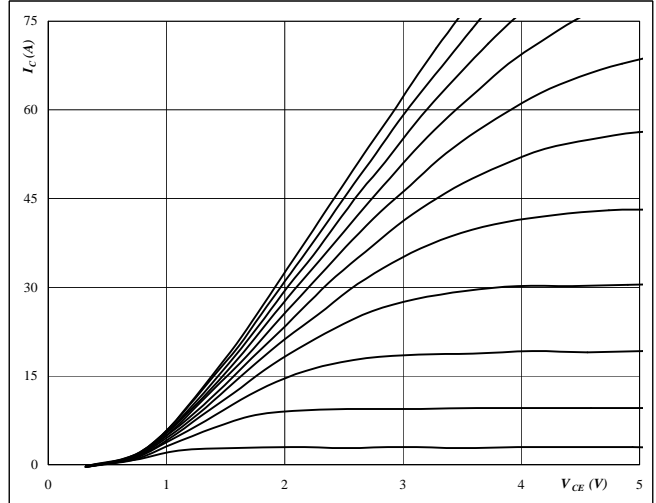
At

 $t_p = 250 \mu s$
 $T_j = 25 \text{ } ^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 Brake IGBT

Typical output characteristics

$I_C = f(V_{CE})$



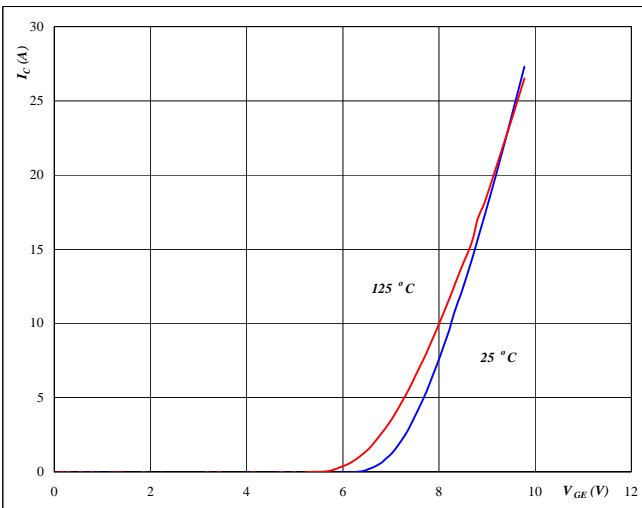
At

 $t_p = 250 \mu s$
 $T_j = 125 \text{ } ^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 Brake IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

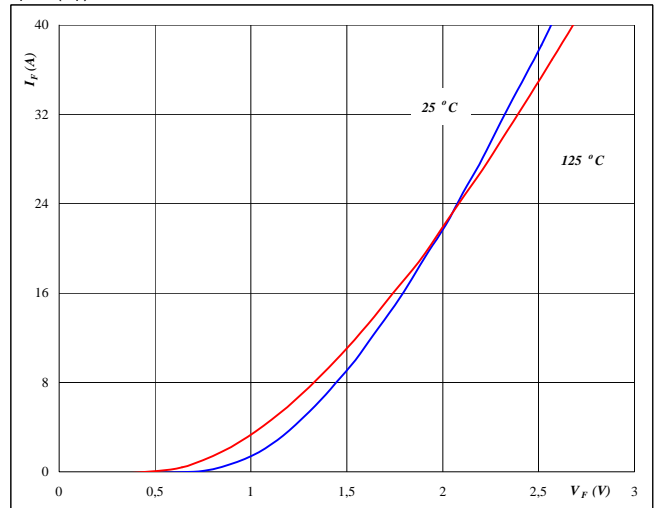


At

 $t_p = 250 \mu s$
 $V_{CE} = 10 \text{ V}$
Figure 4 Brake FRED

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$



At

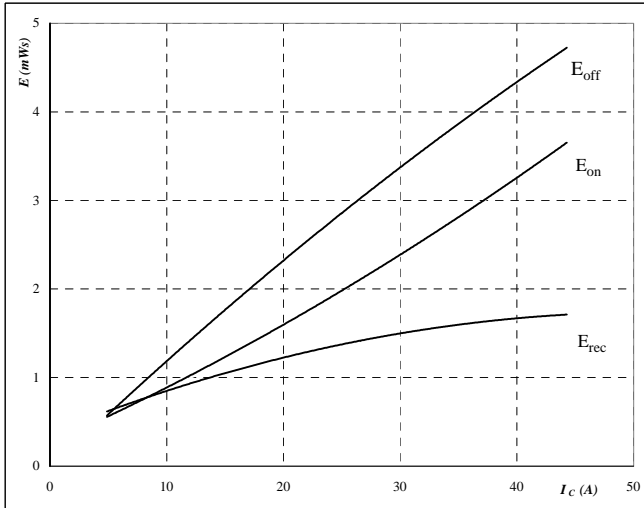
 $t_p = 250 \mu s$

Brake

Figure 5 Brake IGBT

Typical switching energy losses as a function of collector current

$$E = f(I_C)$$



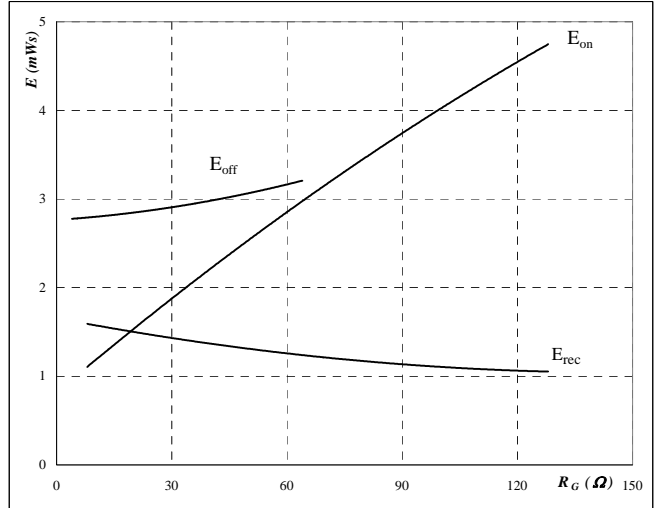
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	15	V
$R_{gon} =$	32	Ω
$R_{goff} =$	16	Ω

Figure 6 Brake IGBT

Typical switching energy losses as a function of gate resistor

$$E = f(R_G)$$



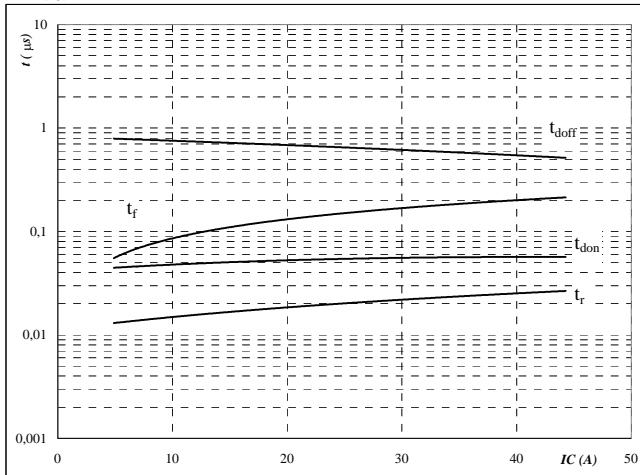
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	15	V
$I_C =$	24	A

Figure 7 Brake IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



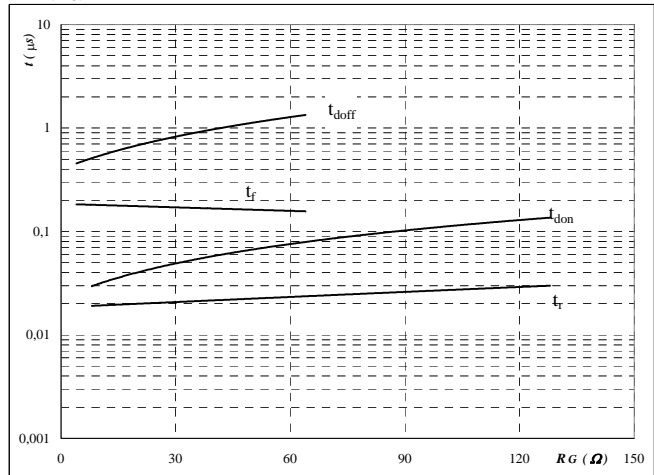
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	15	V
$R_{gon} =$	32	Ω
$R_{goff} =$	16	Ω

Figure 8 Brake IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



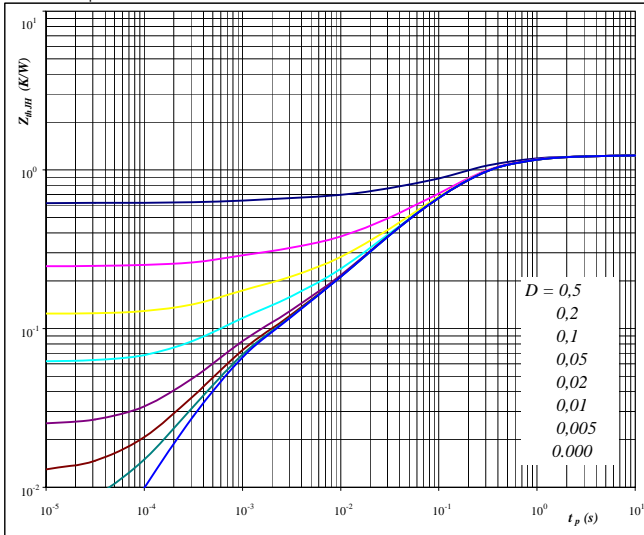
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	600	V
$V_{GE} =$	15	V
$I_C =$	24	A

Brake

Figure 9
**IGBT transient thermal impedance
as a function of pulse width**

$$Z_{thJH} = f(t_p)$$



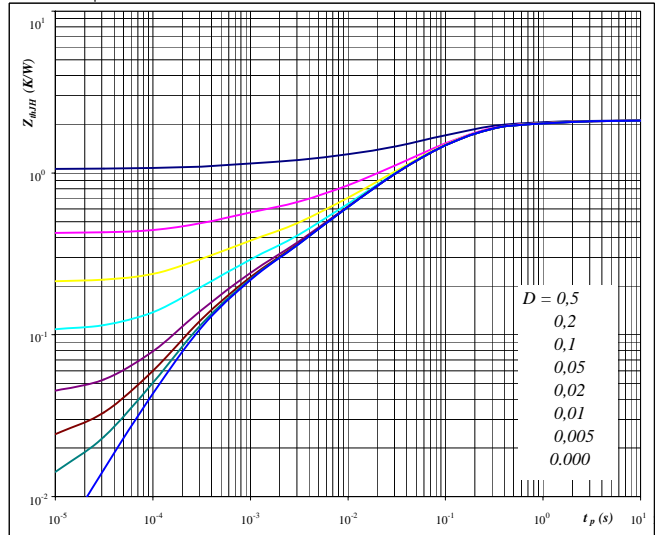
With

$$D = \frac{t_p}{T}$$

$$R_{thJH} = 1,24 \quad \text{K/W}$$

Figure 10
**FRED transient thermal impedance
as a function of pulse width**

$$Z_{thJH} = f(t_p)$$



With

$$D = \frac{t_p}{T}$$

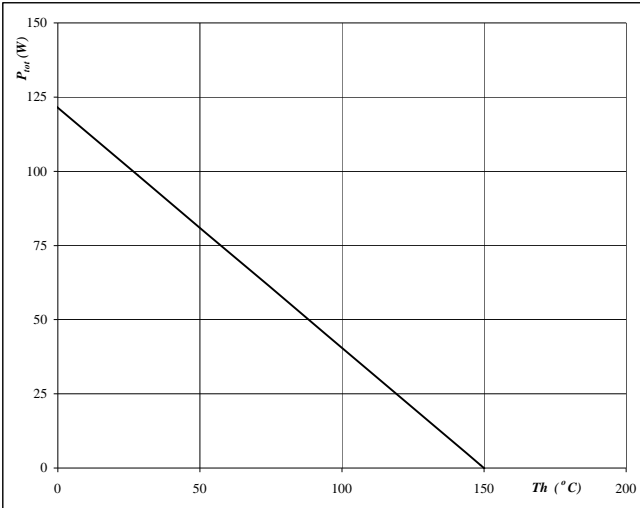
$$R_{thJH} = 2,11 \quad \text{K/W}$$

Brake

Figure 11 Brake IGBT

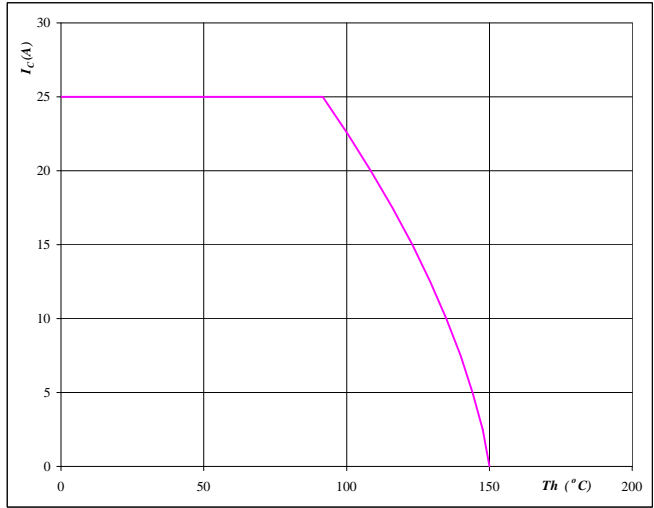
Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


 At
 $T_j = 150 \text{ } ^\circ\text{C}$
Figure 12 Brake IGBT

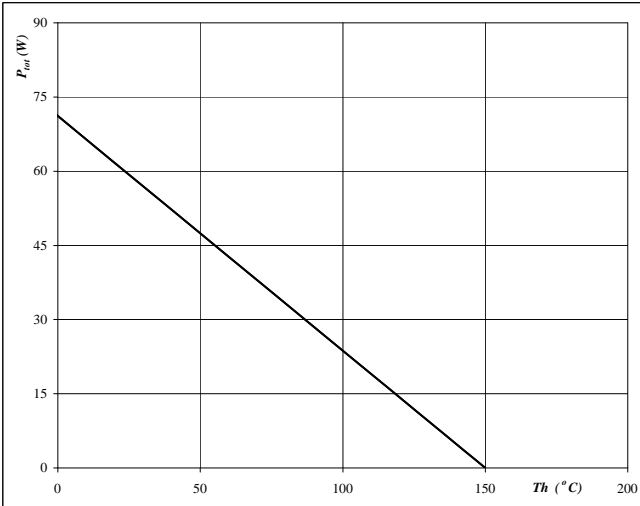
Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$


 At
 $T_j = 150 \text{ } ^\circ\text{C}$
 $V_{GE} = 15 \text{ V}$
Figure 13 Brake FRED

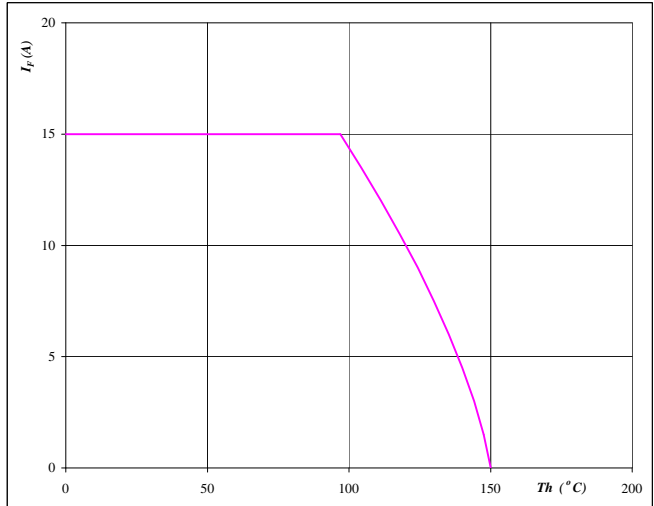
Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


 At
 $T_j = 150 \text{ } ^\circ\text{C}$
Figure 14 Brake FRED

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

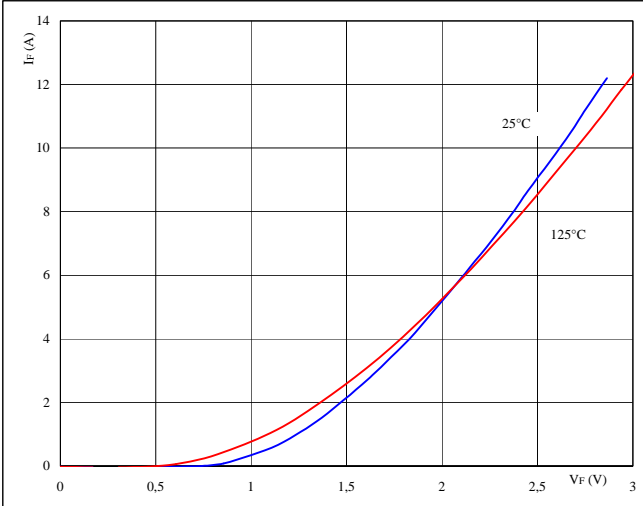

 At
 $T_j = 150 \text{ } ^\circ\text{C}$

Brake Inverse Diode

Figure 1 Brake inverse diode

Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$

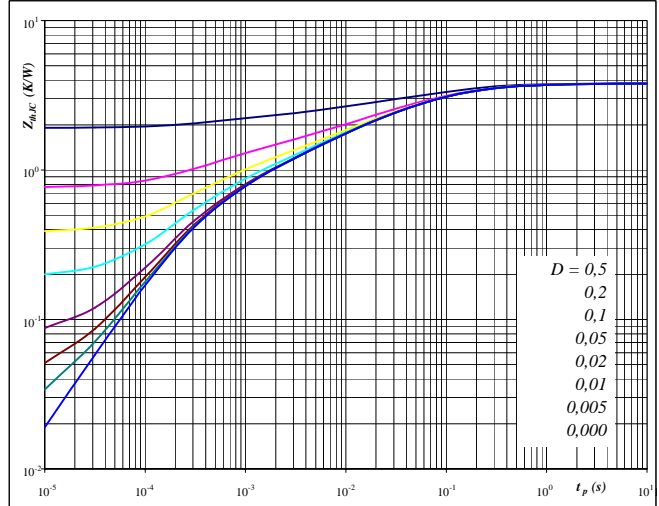


At
 $t_p = 250 \mu s$

Figure 2 Brake inverse diode

Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$

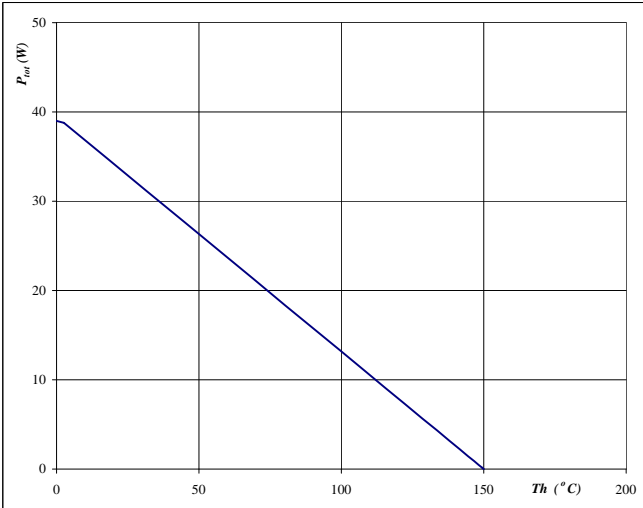


With
 $D = t_p / T$
 $R_{thJH} = 3,80 \text{ K/W}$

Figure 3 Brake inverse diode

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

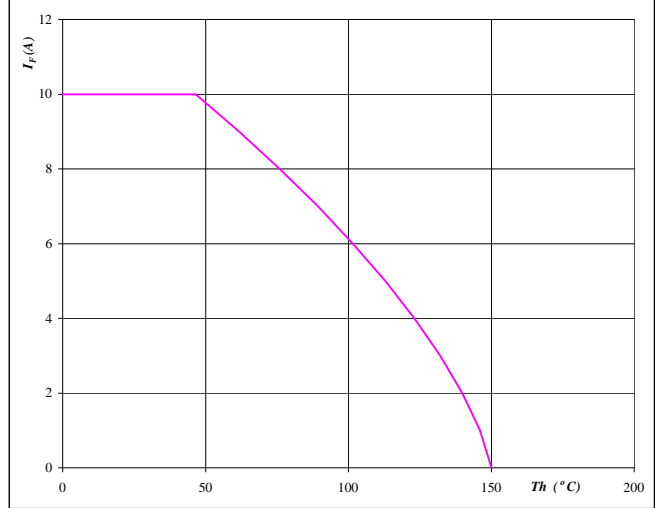


At
 $T_j = 150 \text{ °C}$

Figure 4 Brake inverse diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



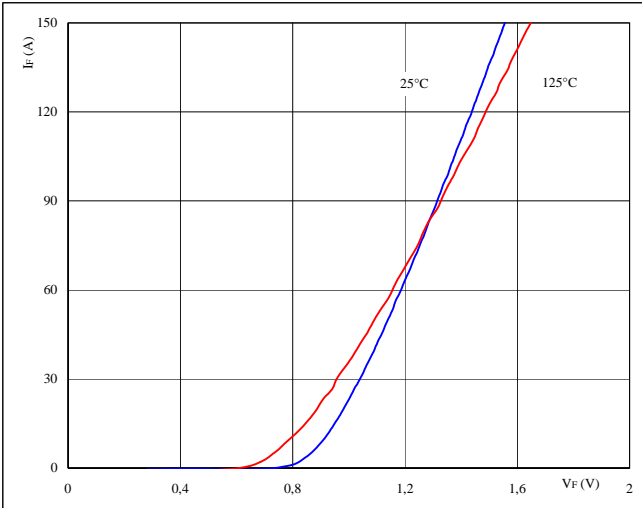
At
 $T_j = 150 \text{ °C}$

Input Rectifier Bridge

Figure 1 Rectifier diode

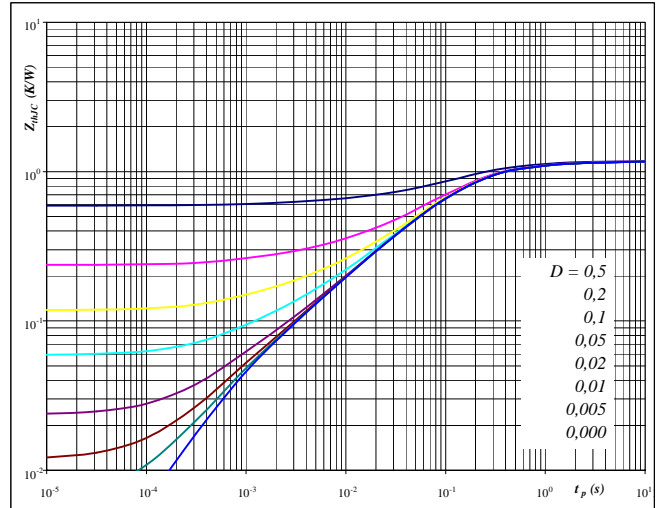
Typical diode forward current as a function of forward voltage

$$I_F = f(V_F)$$


 At $t_p = 250 \mu s$
Figure 2 Rectifier diode

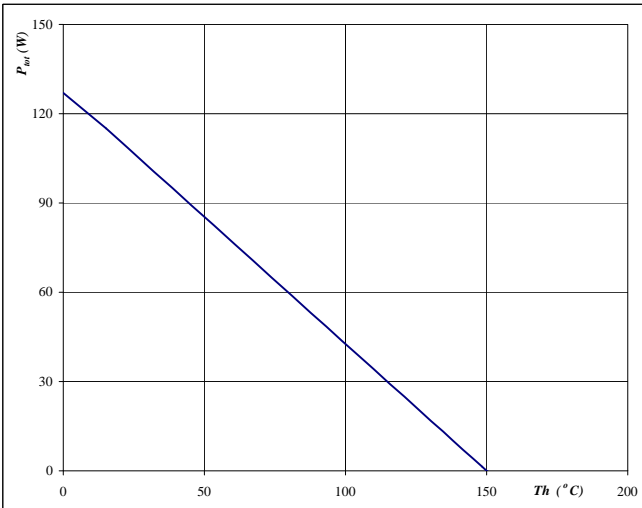
Diode transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$


 With $D = t_p / T$ and \dot{u}
 $R_{thJH} = 1,17 \text{ K/W}$
Figure 3 Rectifier diode

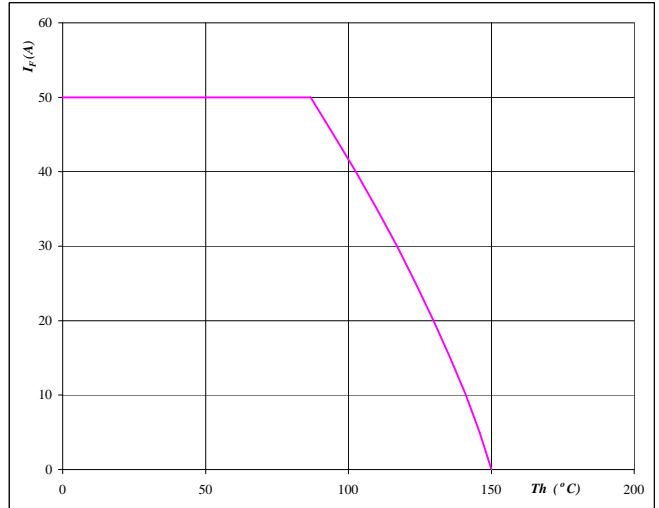
Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$


 At $T_j = 150 \text{ }^\circ\text{C}$
Figure 4 Rectifier diode

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$

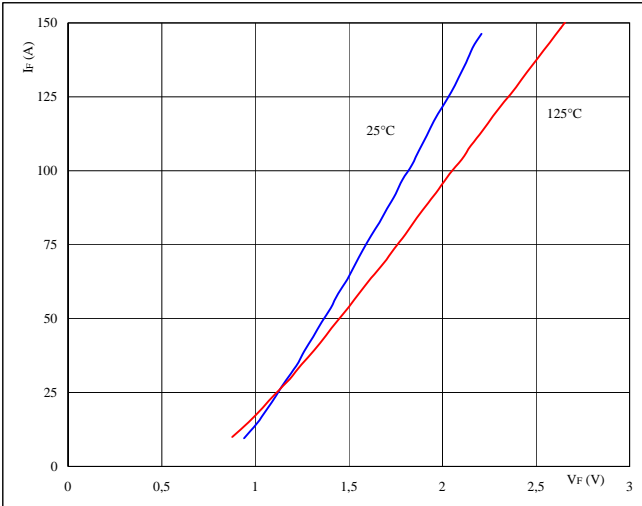

 At $T_j = 150 \text{ }^\circ\text{C}$

Thyristor

Figure 1 Thyristor

Typical thyristor forward current as a function of forward voltage

$$I_F = f(V_F)$$

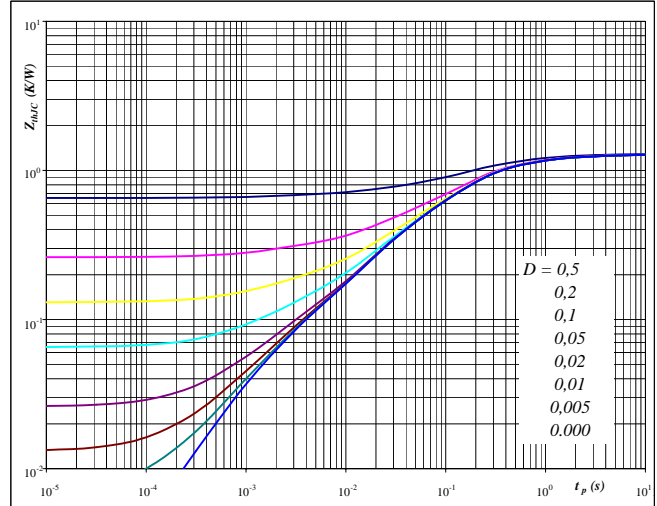


At
 $t_p = 250 \mu s$

Figure 2 Thyristor

Thyristor transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$

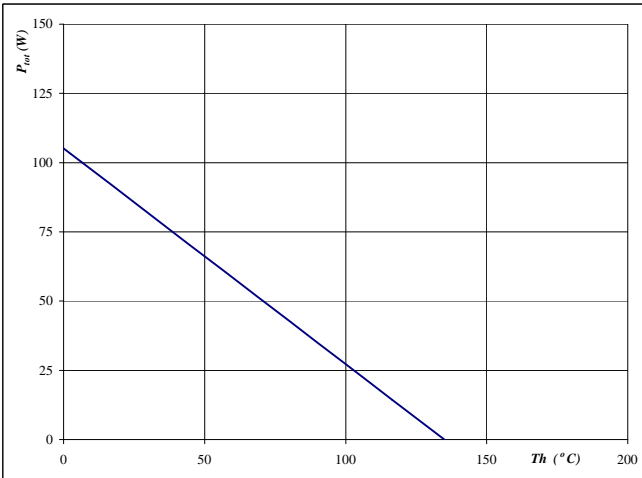


With
 $D = t_p / T$
 $R_{thJH} = 1,28 \text{ K/W}$

Figure 3 Thyristor

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

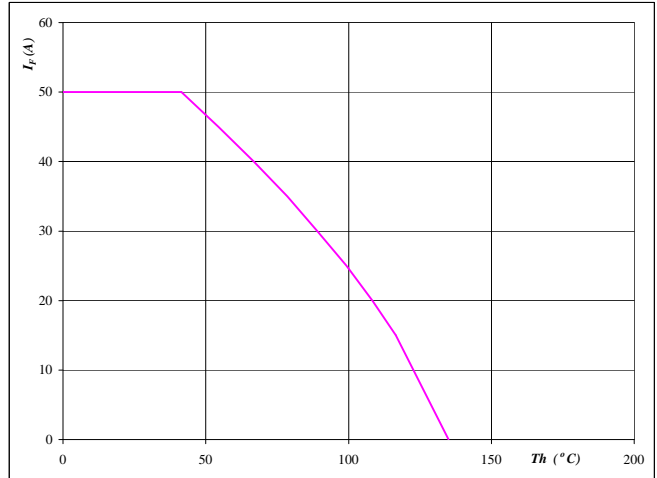


At
 $T_j = 135 \text{ °C}$

Figure 4 Thyristor

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



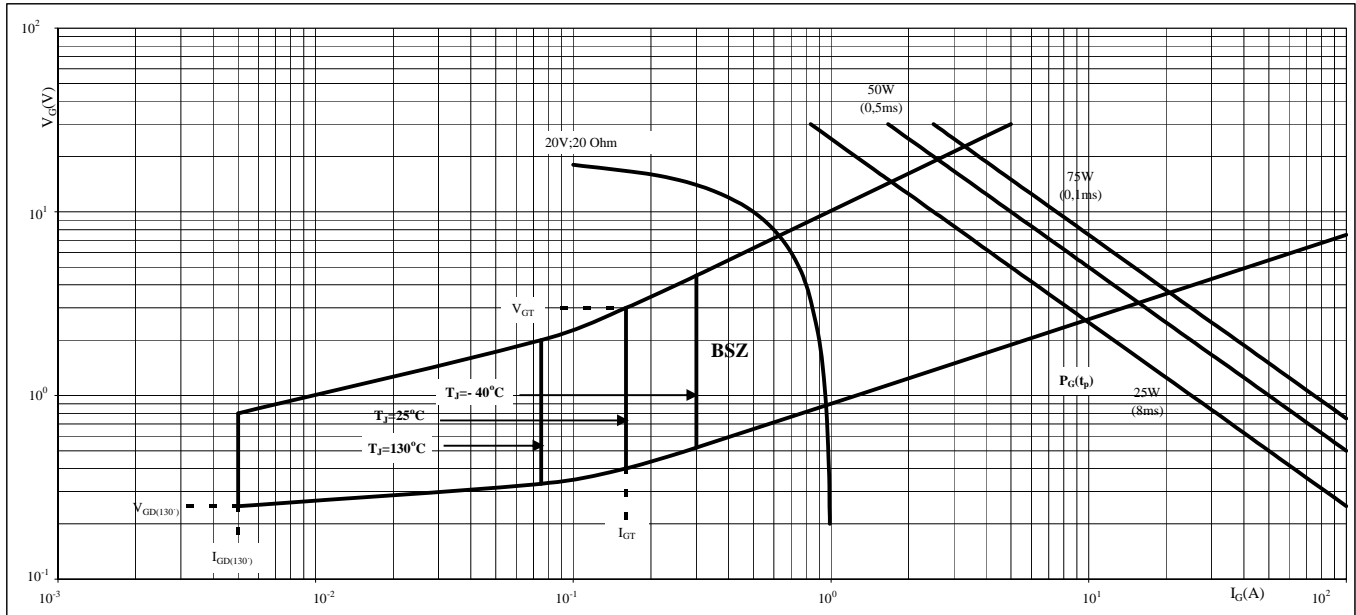
At
 $T_j = 135 \text{ °C}$

Thyristor

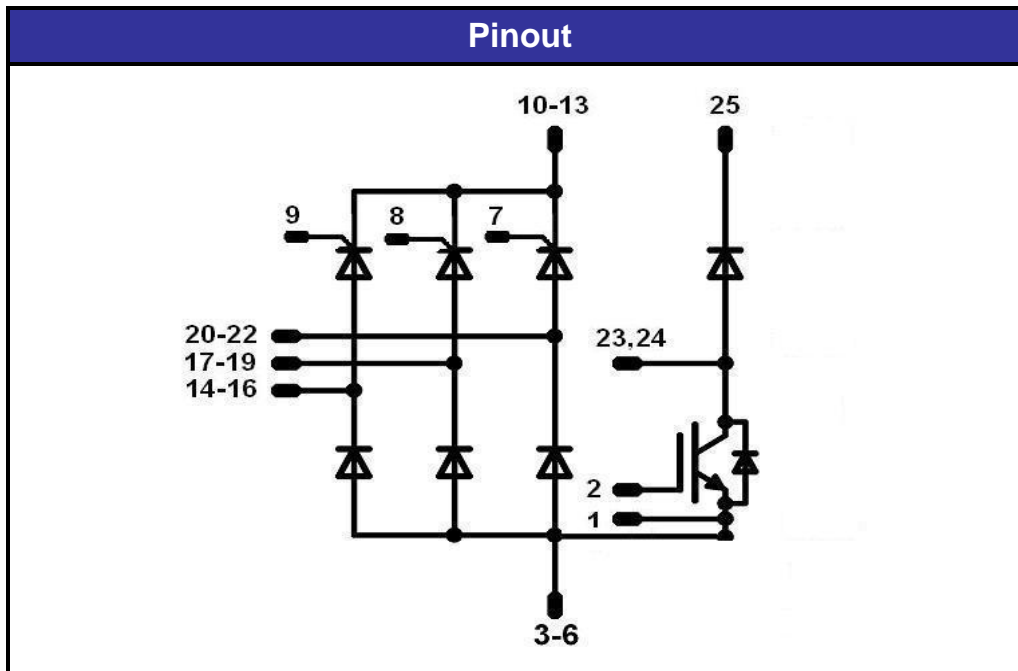
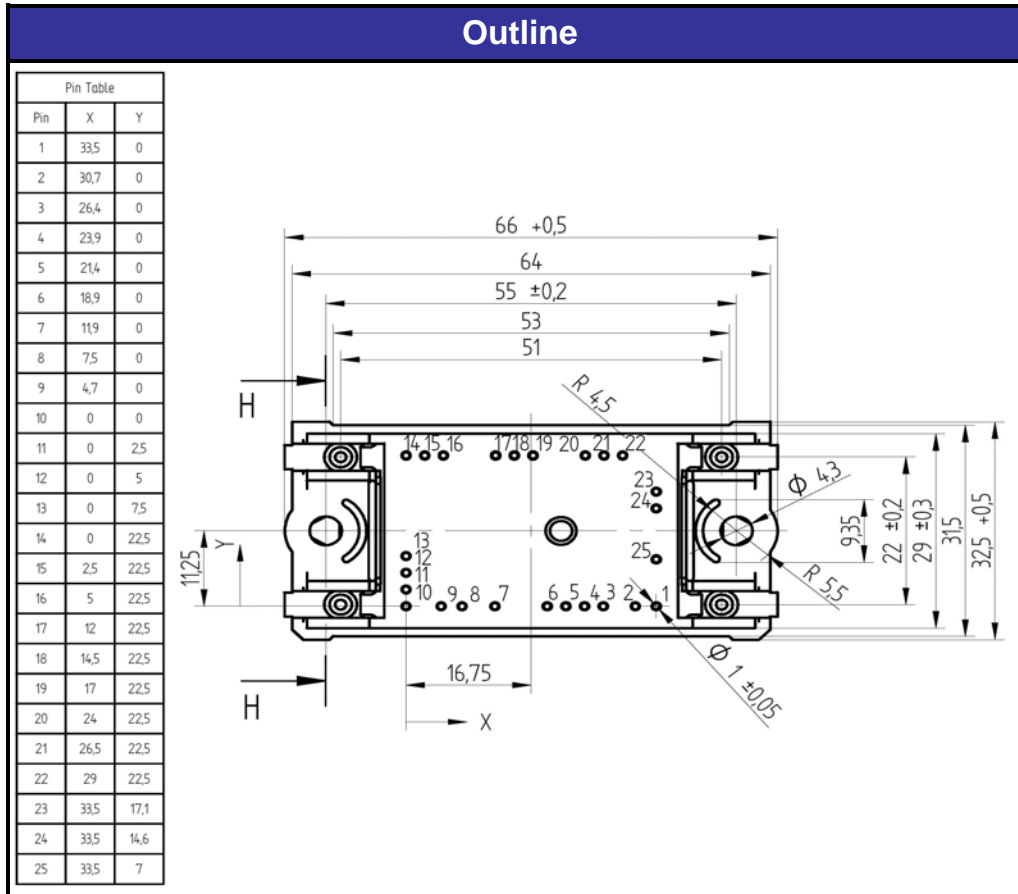
Figure 5

Thyristor

Gate trigger characteristics



Package Outline and Pinout



PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
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